















ESD

TVS

MOS

LDO

Diode

Sensor

DC-DC

Product Specification

Domestic Part Number	IRL3803S
Overseas Part Number	IRL3803S
▶ Equivalent Part Number	IRL3803S





- ★ 100% EAS Guaranteed
- ★ Green Device Available
- ★ Super Low Gate Charge
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology

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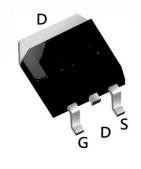
BVDSS RDSON		ID
30V	6mΩ	90A

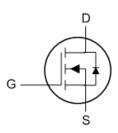
Description

The IRL3803S is the high cell density trenched N-ch MOSFETs, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The IRL3803S meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

TO263 Pin Configuration





Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	90	Α
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	58	Α
ID@TA=25°C	Continuous Drain Current, V _{GS} @ 10V ¹	15	А
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ 10V ¹	12	А
I _{DM}	Pulsed Drain Current ²	180	Α
EAS	Single Pulse Avalanche Energy ³	115	mJ
IAS	Avalanche Current	48	А
P _D @T _C =25°C	D@Tc=25°C Total Power Dissipation⁴		W
P _D @T _A =25°C	Total Power Dissipation ⁴	2	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction-ambient (Steady State) ¹		62	°C/W
R ₀ JC	Thermal Resistance Junction-Case ¹		1.68	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.028		V/°C
D	0	V _{GS} =10V , I _D =30A			6	0
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =15A			9	mΩ
V _{GS(th)}	Gate Threshold Voltage	V V I- 2500A	1.2		2.5	٧
△VGS(th)	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=250uA$		-6.16		mV/°C
la co	Drain Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =30A		43		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.6		Ω
Qg	Total Gate Charge (4.5V)	V _{DS} =15V , V _{GS} =4.5V , I _D =15A		20		
Q _{gs}	Gate-Source Charge			7.6		nC
Q_{gd}	Gate-Drain Charge			7.2		
T _{d(on)}	Turn-On Delay Time			7.8		
T _r	Rise Time	V_{DD} =15V , V_{GS} =10V , R_{G} =3.3 Ω		15		
T _{d(off)}	Turn-Off Delay Time	I _D =15A		37.3		ns
Tf	Fall Time			10.6		
Ciss	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		2295		
Coss	Output Capacitance			267		рF
C _{rss}	Reverse Transfer Capacitance			210		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,5}	Va-Va-OV Force Current			90	Α
I _{SM}	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			180	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1	V
t _{rr}	Reverse Recovery Time			14		nS
Qrr	Reverse Recovery Charge	$I_F=30A$, $dI/dt=100A/\mu s$, $T_J=25$ °C		5		nC

Note

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\,\leq\,300\text{us}$, duty cycle $\,\leq\,2\%$
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =48A
- 4.The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as I_{D} and I_{DM} , in real applications , should be limited by total power dissipation.



Typical Characteristics

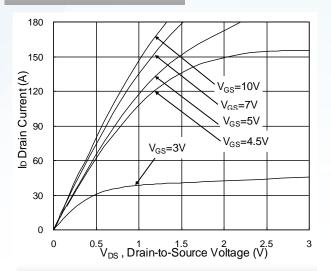


Fig.1 Typical Output Characteristics

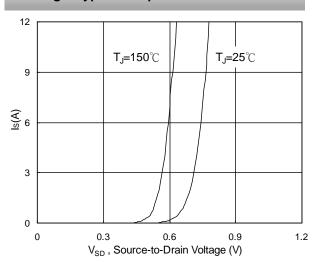


Fig.3 Forward Characteristics of Reverse

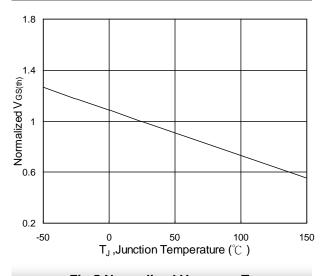


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_{J}

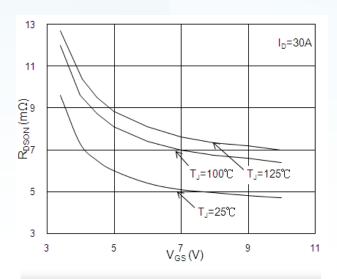


Fig.2 On-Resistance vs. G-S Voltage

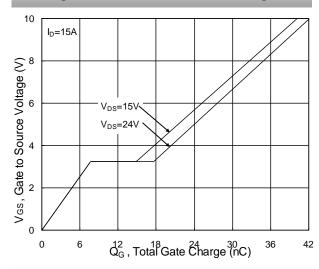


Fig.4 Gate-Charge Characteristics

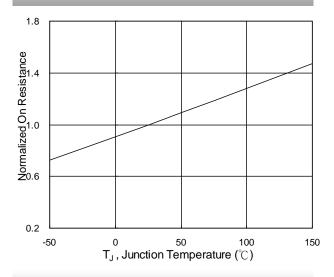
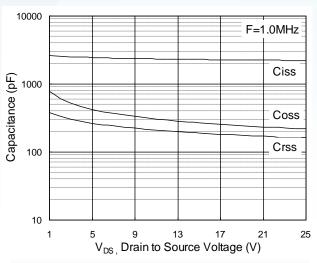


Fig.6 Normalized R_{DSON} vs. T_J





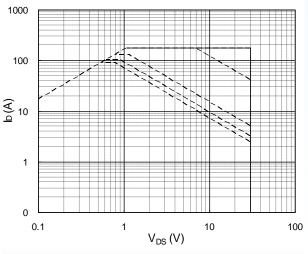
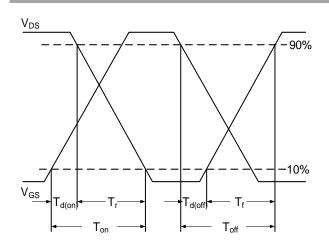


Fig.7 Capacitance Fig.8 Safe Operating Area Normalized Thermal Response (Reuc) 0.2 0.1 0.1 0.05 0.01 SINGLE $D = T_{ON}/T$ 0.001 0.0001 0.001 0.1 0.00001 0.01 10

Fig.9 Normalized Maximum Transient Thermal Impedance

t, Pulse Width (s)





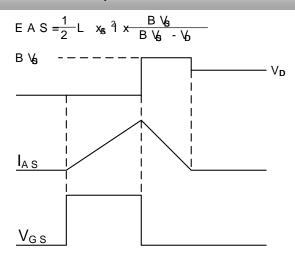


Fig.11 Unclamped Inductive Switching Waveform



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